What if you want to control the Type I errors in your "family" of m tests. (So far in this class, you controlled the Type I error for m=1 test at level alpha). Controlling Type II errors is done by maximizing power (through sample size, through better estimators, etc) so we will ignore that for this discussion.

Why is it important to control the Type I error rate for the m tests? Why not just set alpha like we've been doing all along?

Tanh
$$\frac{H_0}{H_0} \frac{V \cdot N_0}{V \cdot N_0}$$
 $V = K \sim D \text{ in } (N_1 \propto)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = K \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in } (N_1 \sim)$ $V = M \sim D \text{ in }$

Define Family-Wise Type I Error Rate (FWER) as the probability of at least one Type I error ("false negative" or "false discovery")

FWER:=P(V>0)

the collection'

If you can show that FWER \leq FWER $_0 = 5\%$ for every $m_0 \in \{0, ..., m\}$ that is called "strong control of the FWER". This is difficult. We're not going to do it. $^{\circ}$ * If you can show that FWER \leq FWER $_{0}$ = 5% for m = m $_{0}$ (i.e. V = R and no alternatives are true) then this is called "weak control of the FWER". We'll focus on this.

The following is called the "Bonferroni Correction" for FWER. It does not require independence among the m hypothesis tests. Let $R_I=1$ if first null is rejected and 0 if retained Let $R_Z=1$ if second null is rejected and 0 if retained

 $R = \int_{a}^{c} R_{p} \propto \alpha$ is Type I error setting for an individual test

$$\leq \mathcal{E} \rho(A_i)$$
 Boole's Inequali

don't expect to find many things!

If we assume the tests are independent we can do slightly better. Recall from above that R
$$\sim$$
 Bin(m, α) so...

P(R > 0) = 1-(1-x)" = FWERO

 $\Rightarrow \propto_{05} = \left| - \left(1 - \text{FWE } \mathbf{r}_o \right)^{1/n_0}$

Dunn-Sidak Correction, 1967
$$\propto_{6} = .05\%, \quad \propto_{0.5} = .05\%, \quad \text{which is slightly better but nothing to write home about}$$

Sidak we used one "adjusted" alpha level for all tests. Here, we use a different alpha in each test and this gives us more power. We first run all tests and collected pval_1 , pval_2 , ..., pval_k . Remember, the pval measures the "strength of the rejection" e.g. a pval of 0.0001 is much "more of a rejection than a pval of 0.01 even though they're both "statistically significant" at 5%. Now, sort the pvals $p_{(i)} \leq p_{(i)} \leq \ldots \leq p_{(k)}$ where $p_{(i)}$ is the smallest pval and $p_{(k)}$ is the largest pval. Then, locate: ax := max { a; P(a) < FWER, and

or let it be zero if the max doesn't exist i.e. that rhs condition is never fulfilled. This is called "linear step-up". At a = 1, the rhs is the Bonferroni level, at a = 2, it's larger, at a = 3, larger,... and a = m it is $FWER_{\odot}$. Equivalently you can also calculate adjusted pvals as follows:

ax := max {a: P(a):= 1/2 P(a) < FWERO}

Then, you reject all tests with p vals
$$p_0$$
, ..., p_0 and retain all other tests. In this procedure you will likely get more rejections hence more power with the same FWER control.

Then in the 1990's people started to ask the question "is F

Then in the 1990's people started to ask the question "is FWER really what we should be so worried about?" Maybe instead you should care about the proportion of false discoveries i.e. the False Discovery Proportion (FDP) *not* whether you made one or more! Let's control the expected FDP which we will call False Discover Rate (FDR), Those the case when R=0 $FDR := E[FDP] = E\left[\frac{V}{R} \mathcal{1}_{R>0}\right]$

We don't control FDP directly since V/R is a rv and we need to pick metrics about the rv to control. How about the expectation? That seems like a good place to start. Hence FDR control. So let's say we control FDR \leq FDR and we do m = 1000 tests and get r = 100 rejections. Then we expect \leq 5 of these rejections to be Type I errors and \geq 95 to be justified rejections (discoveries). Expect means if you ran m = 1000 test family many times.

FOR = E FOPT = FWER

If $m = m_{\ell_f}$ then FWER = FDR since V = R then

FDR applies in cases where
$$m_o < m$$
 unlike the weak control of FWER we discussed before. Thm. Benjamini & Hochberg (1995) proved the Simes procedure controls FDR for any m_o . In fact they proved

 $FDP = \begin{cases} 1 & \text{if } R > 0 \\ 0 & \text{if } R = 0 \end{cases} \Rightarrow FOP \sim Bern \left(PR > 0\right) = Bern \left(FWER\right)$

so the FDR could be substantially smaller than advertised depending on $\rm m_{\it o}.$ Proof beyond scope of course.